### **VE 320 Summer 2019**

### Introduction to Semiconductor Devices

Instructor: Rui Yang (杨睿)

Office: JI Building 434

rui.yang@sjtu.edu.cn

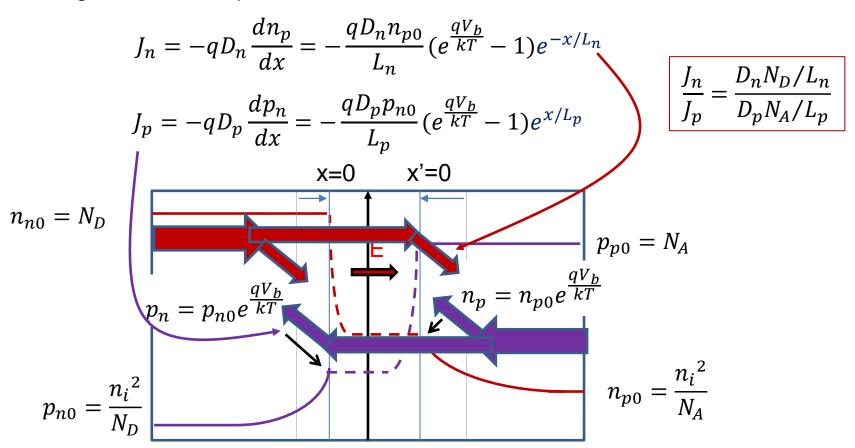


# Lecture 9

BJT (Chapter 12)

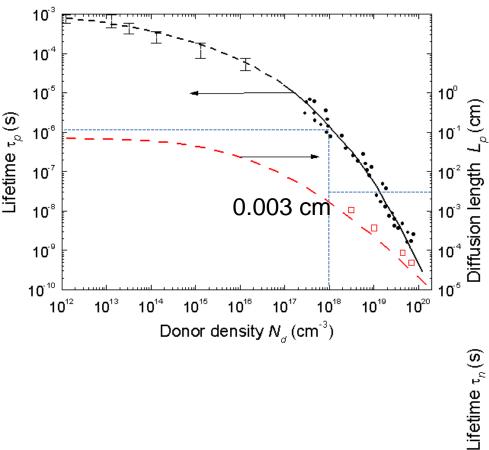
## Previously: pn Junction Current

charge carrier transport: <u>forward bias: current ratio</u>



Assumption: No recombination-generation in depletion region.

### Example: pn Junction Current



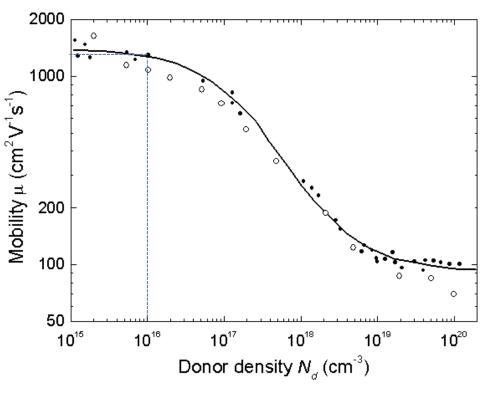
 $N_D = 10^{18} \text{ cm}^{-3}, N_A = 10^{16} \text{ cm}^{-3}$  $L_n = 0.04 \text{ cm}, L_p = 0.003 \text{ cm}$ 

$$\frac{J_n}{J_p} = \frac{D_n N_D / L_n}{D_p N_A / L_p}$$

10<sup>.3</sup> 10<sup>-4</sup> 10<sup>.5</sup> 10<sup>-6</sup> 0.04 cm 10<sup>-7</sup> 10° 10<sup>.9</sup> 1012 10<sup>14</sup> 10<sup>15</sup> 10<sup>16</sup> 10<sup>17</sup> 10<sup>18</sup> 10<sup>19</sup> 10<sup>20</sup> Acceptor density N<sub>g</sub> (cm<sup>-3</sup>)

http://www.ioffe.ru/SVA/NSM/Semicond/Siz

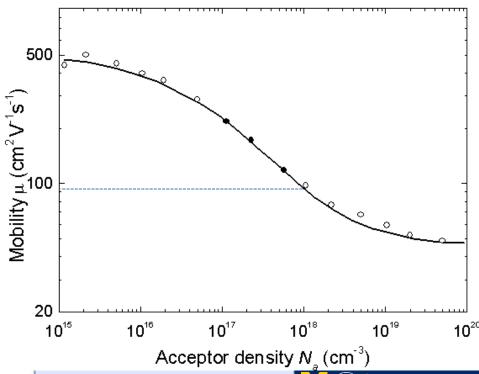
### Example: pn Junction Current



http://www.ioffe.ru/SVA/NSM/Semicond/Si/

$$\begin{split} N_D &= 10^{18}\,\text{cm}^{-3},\, N_A \text{=} 10^{16}\,\text{cm}^{-3} \\ L_n &= 0.04\text{cm},\, L_p \text{=} 0.003\text{cm} \\ \mu_p &= 100\text{cm}^2/\text{Vs} \;\; \mu_n \text{=} \; 1300 \;\text{cm}^2/\text{Vs} \end{split}$$

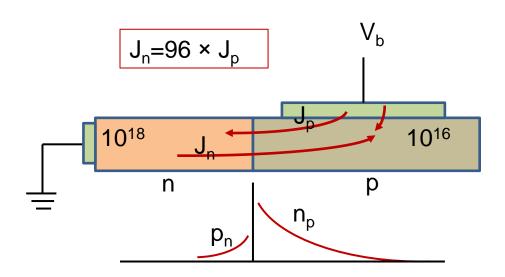
$$\frac{J_n}{J_p} = \frac{D_n N_D / L_n}{D_p N_A / L_p}$$



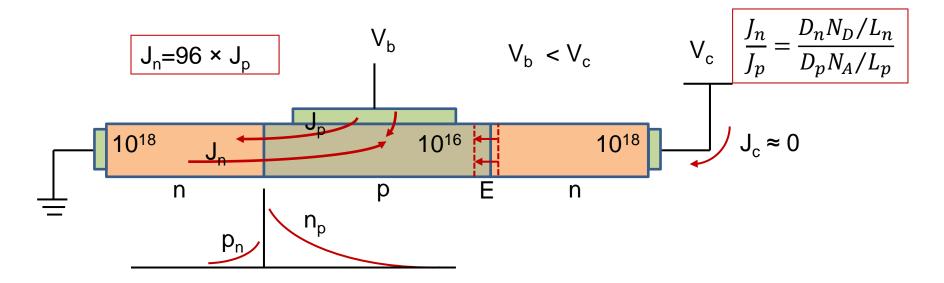
### Example: pn Junction Current

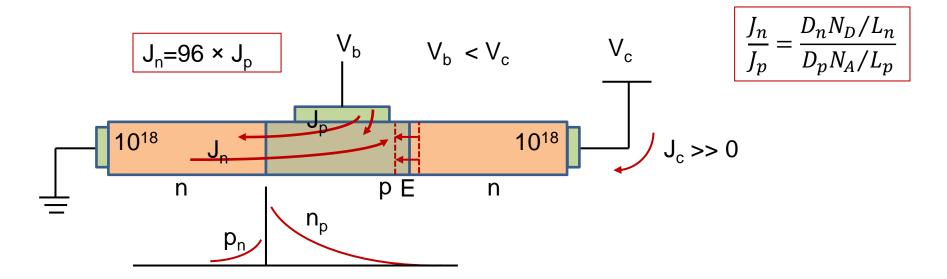
$$\begin{split} N_D &= 10^{18}\,\text{cm}^{\text{-}3},\, N_A \text{=} 10^{16}\,\text{cm}^{\text{-}3} \\ L_n &= 0.04\text{cm},\, L_p \text{=} 0.003\text{cm} \\ \mu_p &= 100\text{cm}^2/\text{Vs} \,\,\, \mu_n \text{=} \,\, 1300\,\,\text{cm}^2/\text{Vs} \end{split}$$

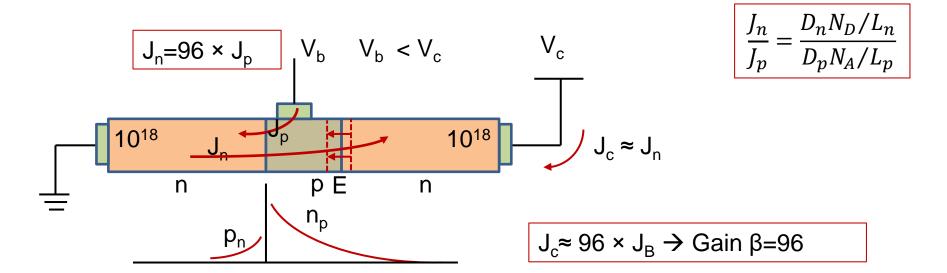
$$\frac{J_n}{J_p} = \frac{D_n N_D / L_n}{D_p N_A / L_p} = \frac{1300 \times 10^{18} / 0.04}{100 \times 10^{16} / 0.003} = 97.5$$

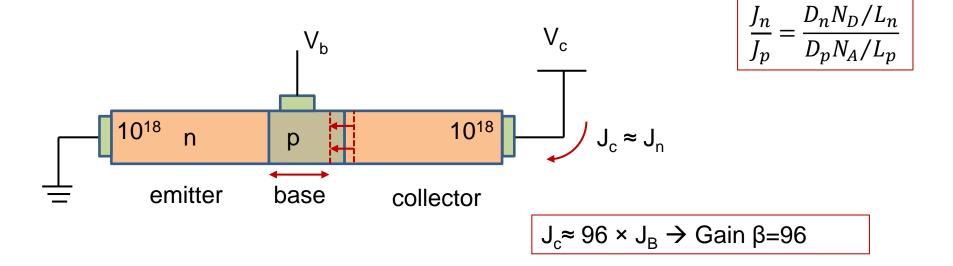


$$\frac{J_n}{J_p} = \frac{D_n N_D / L_n}{D_p N_A / L_p}$$



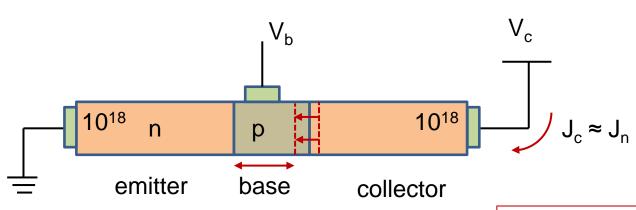






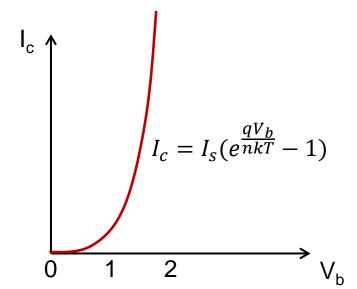
#### **BJT Charateristics:**

- 1. Base width smaller → higher gain
- 2. Larger emitter-base concentration ratio → higher gain

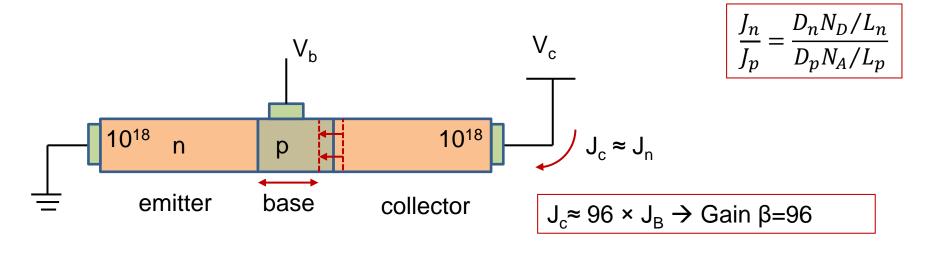


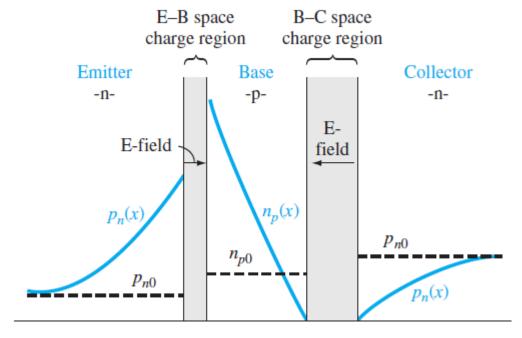
$$\frac{J_n}{J_p} = \frac{D_n N_D / L_n}{D_p N_A / L_p}$$

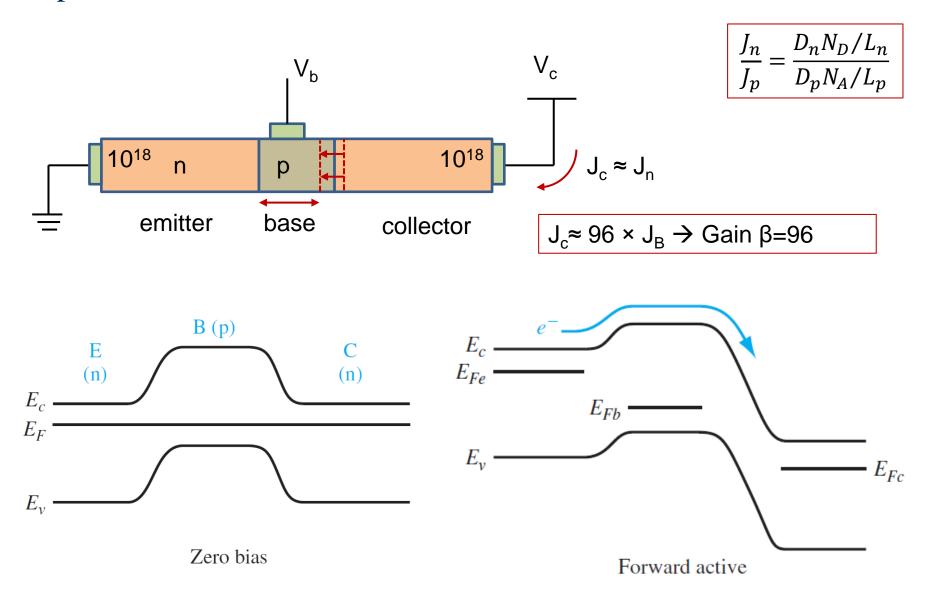
$$J_c \approx 96 \times J_B \rightarrow Gain \beta = 96$$

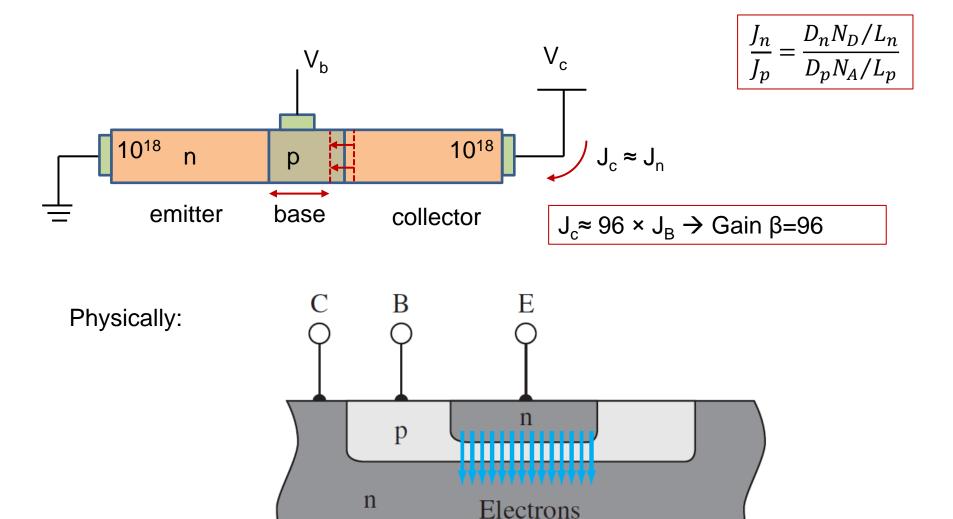


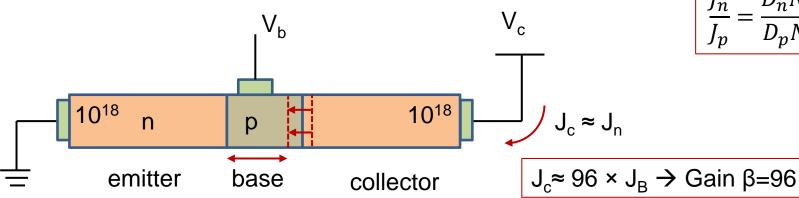
B-E junction forward biased, B-C junction reverse biased: forward-active operating mode









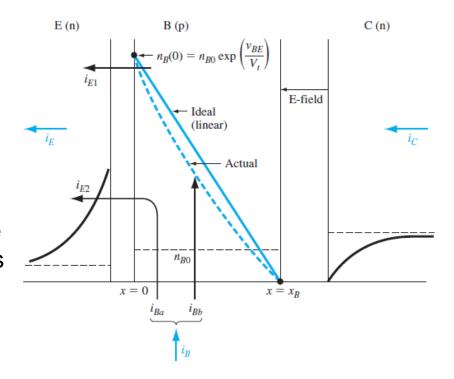


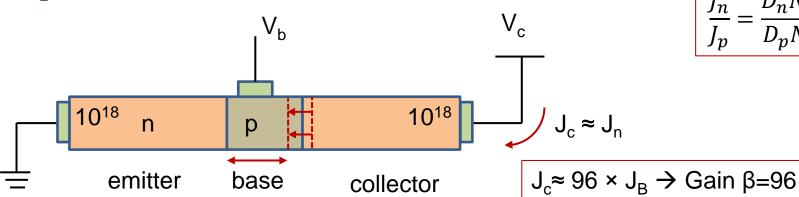
$$\frac{J_n}{J_p} = \frac{D_n N_D / L_n}{D_p N_A / L_p}$$

Qualitative *I-V*:

$$i_C = I_S \exp\left(\frac{\nu_{BE}}{V_t}\right)$$

The collector current is controlled by the base–emitter voltage: the current at one terminal of the device is controlled by the voltage applied to the other two terminals of the device





$$\frac{J_n}{J_p} = \frac{D_n N_D / L_n}{D_p N_A / L_p}$$

#### Qualitative *I-V*:

Injected holes produce  $i_{E2}$ 

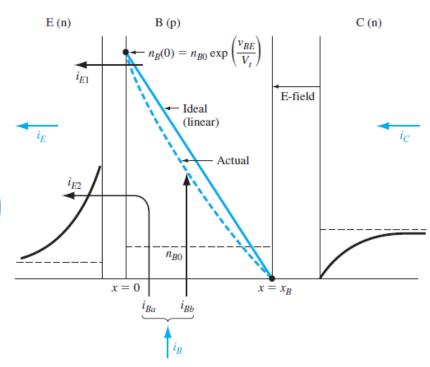
$$i_{E2} = I_{S2} \exp\left(\frac{\nu_{BE}}{V_t}\right)$$

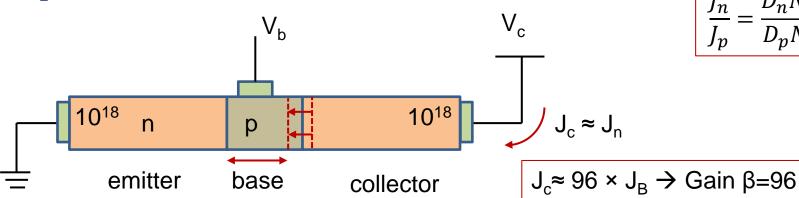
Injected electrons produce  $i_{\text{F1}}$ 

$$i_E = i_{E1} + i_{E2} = i_C + i_{E2} = I_{SE} \exp\left(\frac{\nu_{BE}}{V_t}\right)$$

Common-base current gain

$$\frac{i_C}{i_E} \equiv \alpha$$





$$\frac{J_n}{J_p} = \frac{D_n N_D / L_n}{D_p N_A / L_p}$$

#### Qualitative *I-V*:

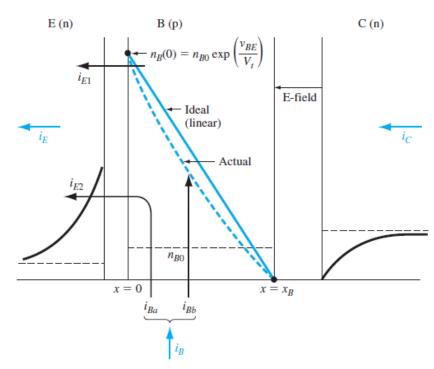
Injected holes produce  $i_{E2} = i_{Ba}$ 

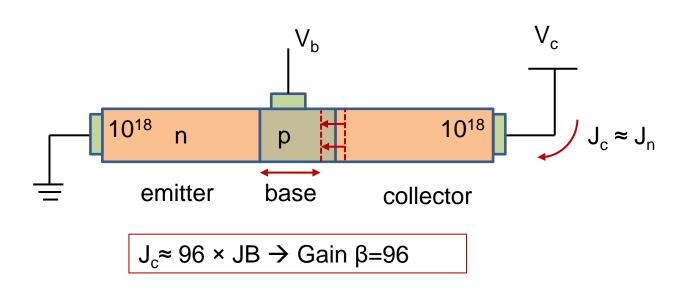
Recombination in the base: re-supply of holes by flow of positive charge, current  $i_{Bb}$ 

The number of holes per unit time recombining in the base is directly related to the number of minority carrier electrons in the base, so  $i_{Bb}$  is also proportional to  $\exp(\nu_{BE}/V_t)$ 

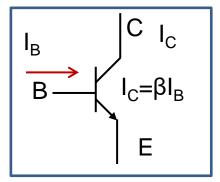
### Common-emitter current gain

$$\frac{i_C}{i_B} \equiv \beta$$



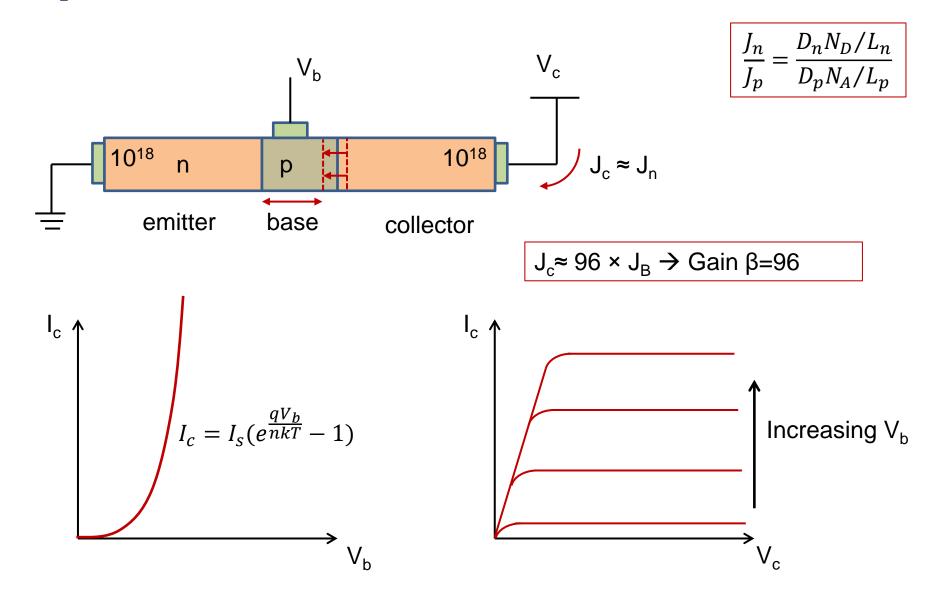


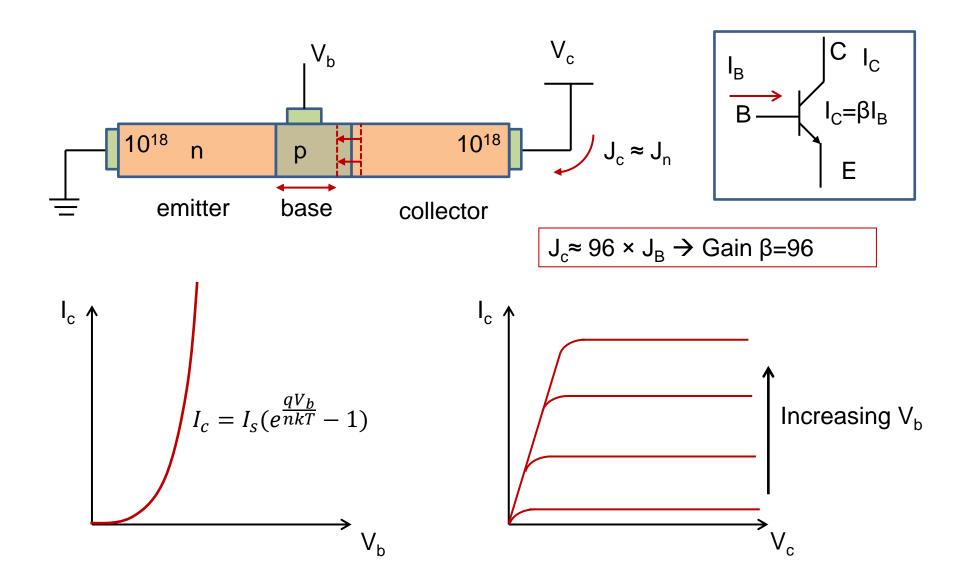
$$\frac{J_n}{J_p} = \frac{D_n N_D / L_n}{D_p N_A / L_p}$$

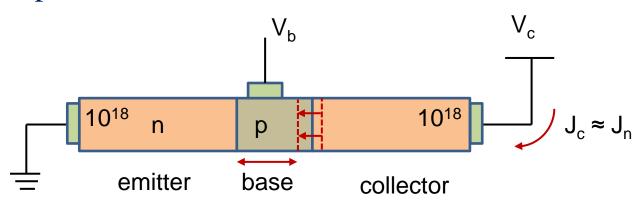


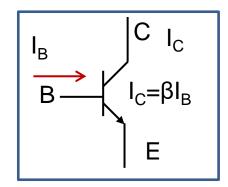
#### Basic facts:

- 1. Narrower base → larger gain
- 2.  $\beta \approx N_d/N_a$ , higher emitter-to-base doping ratio  $\rightarrow$  higher gain









Three modes of operation:

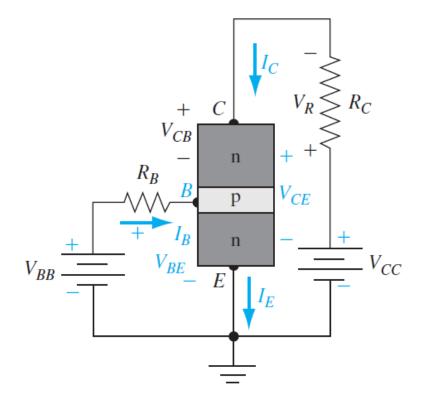
1. Cutoff: B-E zero or reverse biased, B-C reverse biased.

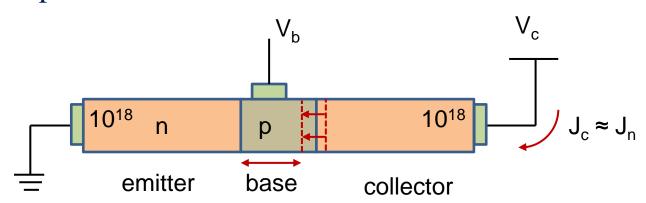
Emitter and collector currents are zero

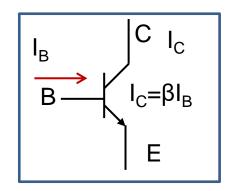
2. Forward-active: B-E forward biased, B-C reverse biased.  $V_{\rm cc}$  large enough,  $V_{\rm R}$  small enough,  $V_{\rm CB}$ >0. KVL

$$V_{CC} = I_C R_C + V_{CB} + V_{BE} = V_R + V_{CE}$$

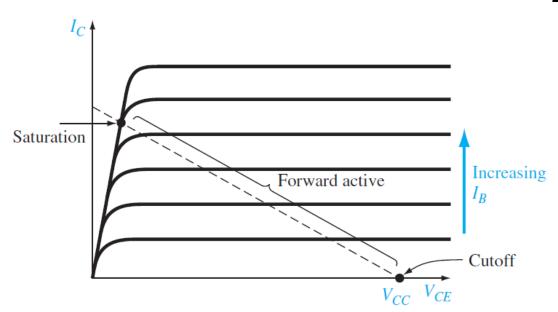
3. Saturation: both B-E and B-C junctions are forward-biased, so that  $I_{\rm C}$  is no longer controlled by  $V_{\rm BE}$ .  $V_{\rm BE}$  increase,  $V_{\rm R}$  increases and  $I_{\rm C}$  increases





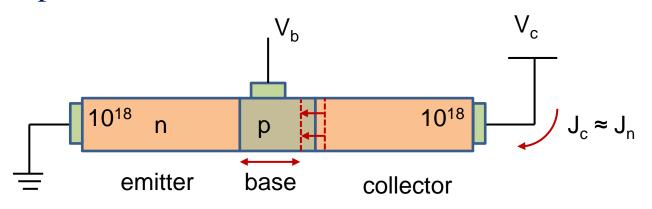


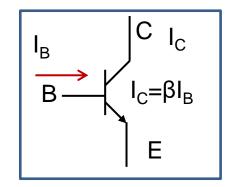
 $I_{C}$ - $V_{CE}$ :

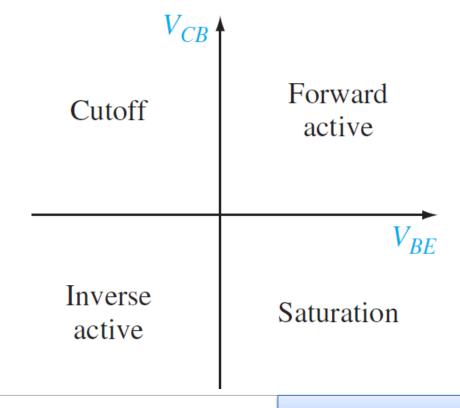


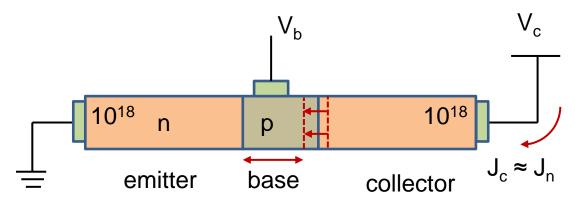
Load line

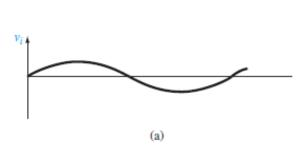
$$V_{CE} = V_{CC} - I_C R_C$$



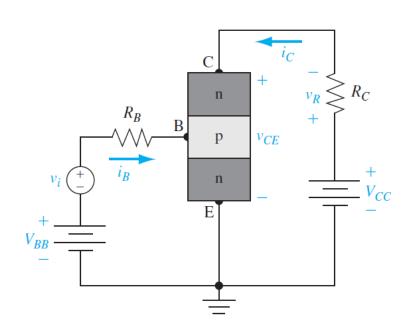


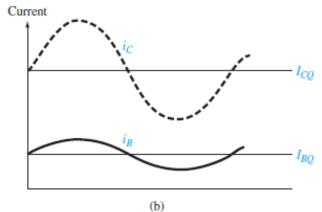


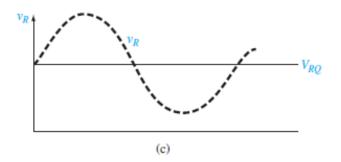


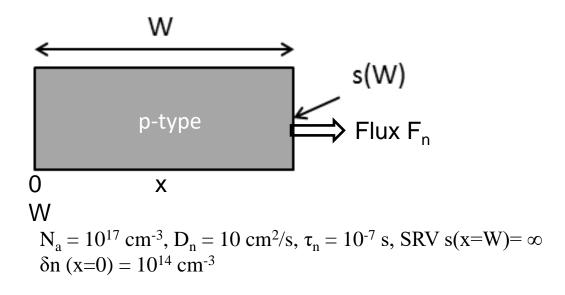


### Small signal voltage gain



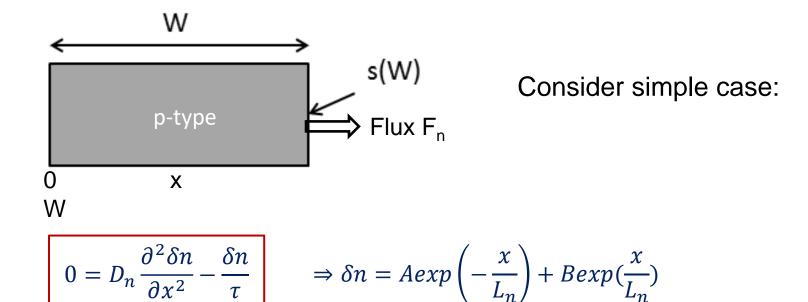


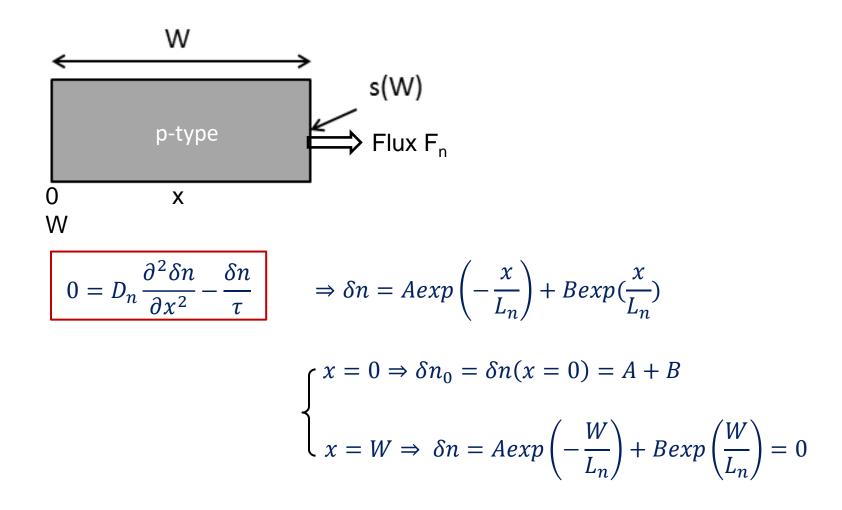


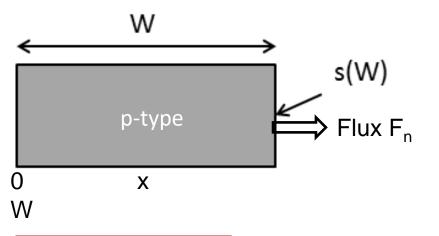


Find the electron flux Fn at x=0 and W, if

- 1) W=20um
- 2) W=2um

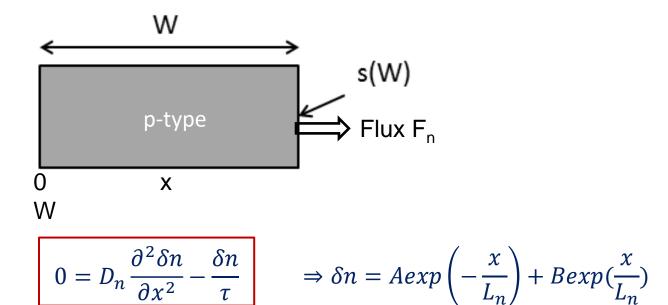




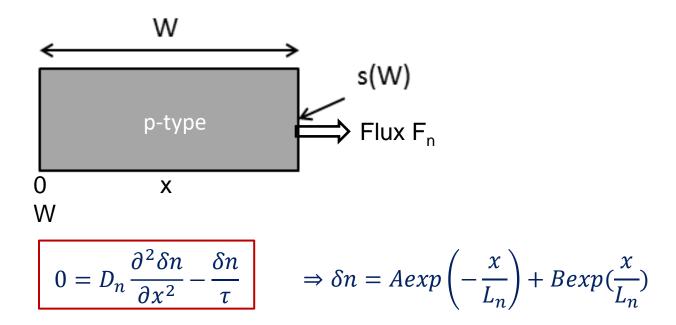


$$0 = D_n \frac{\partial^2 \delta n}{\partial x^2} - \frac{\delta n}{\tau} \qquad \Rightarrow \delta n = Aexp\left(-\frac{x}{L_n}\right) + Bexp\left(\frac{x}{L_n}\right)$$

$$A = (\delta n)_0 \frac{\exp\left(\frac{W}{L_n}\right)}{\exp\left(\frac{W}{L_n}\right) - \exp\left(-\frac{W}{L_n}\right)} \qquad B = -(\delta n)_0 \frac{\exp\left(-\frac{W}{L_n}\right)}{\exp\left(\frac{W}{L_n}\right) - \exp\left(-\frac{W}{L_n}\right)}$$



$$\delta n(x) = (\delta n)_0 \frac{\sinh\left(\frac{W - x}{L_n}\right)}{\sinh\left(\frac{W}{L_n}\right)}$$



$$\delta n(x) = (\delta n)_0 \frac{\sinh\left(\frac{W-x}{L_n}\right)}{\sinh\left(\frac{W}{L_n}\right)} \qquad F_n = -D_n \frac{d\delta n(x)}{dx} = \frac{D_n(\delta n)_0}{L_n} \frac{\cosh\left(\frac{W-x}{L_p}\right)}{\sinh\left(\frac{W}{L_p}\right)}$$

